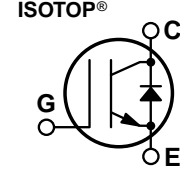
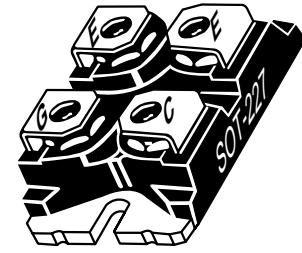


### Fast IGBT & FRED

The Fast IGBT™ is a new generation of high voltage power IGBTs. Using Non-Punch Through™ Technology the Fast IGBT™ combined with an APT free-wheeling ultraFast Recovery Epitaxial Diode (FRED) offers superior ruggedness and fast switching speed.

- Low Forward Voltage Drop
- Low Tail Current
- RBSOA and SCSOA Rated
- Ultrafast Soft Recovery Antiparallel Diode
- High Freq. Switching to 20KHz
- Ultra Low Leakage Current



#### MAXIMUM RATINGS (IGBT)

All Ratings:  $T_C = 25^\circ\text{C}$  unless otherwise specified.

Symbol	Parameter	APT60GF120JRD	UNIT
$V_{CES}$	Collector-Emitter Voltage	1200	Volts
$V_{CGR}$	Collector-Gate Voltage ( $R_{GE} = 20K\Omega$ )	1200	
$V_{GE}$	Gate-Emitter Voltage	$\pm 20$	
$I_{C1}$	Continuous Collector Current @ $T_C = 25^\circ\text{C}$	100	Amps
$I_{C2}$	Continuous Collector Current @ $T_C = 90^\circ\text{C}$	60	
$I_{CM1}$	Pulsed Collector Current <sup>①</sup> @ $T_C = 25^\circ\text{C}$	200	
$I_{CM2}$	Pulsed Collector Current <sup>①</sup> @ $T_C = 90^\circ\text{C}$	120	
$P_D$	Total Power Dissipation	520	Watts
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to 150	$^\circ\text{C}$
$T_L$	Max. Lead Temp. for Soldering: 0.063" from Case for 10 Sec.	300	

#### STATIC ELECTRICAL CHARACTERISTICS (IGBT)

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$BV_{CES}$	Collector-Emitter Breakdown Voltage ( $V_{GE} = 0V, I_C = 1.0mA$ )	1200			Volts
$V_{GE(TH)}$	Gate Threshold Voltage ( $V_{CE} = V_{GE}, I_C = 700\mu A, T_J = 25^\circ\text{C}$ )	4.5	5.5	6.5	
$V_{CE(ON)}$	Collector-Emitter On Voltage ( $V_{GE} = 15V, I_C = 40A, T_J = 25^\circ\text{C}$ )		2.9	3.4	
	Collector-Emitter On Voltage ( $V_{GE} = 15V, I_C = 40A, T_J = 125^\circ\text{C}$ )		3.5	4.1	
$I_{CES}$	Collector Cut-off Current ( $V_{CE} = V_{CES}, V_{GE} = 0V, T_J = 25^\circ\text{C}$ ) <sup>②</sup>			1.0	mA
	Collector Cut-off Current ( $V_{CE} = V_{CES}, V_{GE} = 0V, T_J = 125^\circ\text{C}$ ) <sup>②</sup>			TBD	
$I_{GES}$	Gate-Emitter Leakage Current ( $V_{GE} = \pm 20V, V_{CE} = 0V$ )			$\pm 100$	nA

 **CAUTION:** These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

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**DYNAMIC CHARACTERISTICS (IGBT)**

**APT60GF120JRD**

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
C <sub>ies</sub>	Input Capacitance	<b>Capacitance</b> V <sub>GE</sub> = 0V V <sub>CE</sub> = 25V f = 1 MHz		7200	9600	pF
C <sub>oes</sub>	Output Capacitance			790	1100	
C <sub>res</sub>	Reverse Transfer Capacitance			420	630	
Q <sub>g</sub>	Total Gate Charge <sup>③</sup>	<b>Gate Charge</b> V <sub>GE</sub> = 15V V <sub>CC</sub> = 0.5V <sub>CES</sub> I <sub>C</sub> = I <sub>C2</sub>		690		nC
Q <sub>ge</sub>	Gate-Emitter Charge			55		
Q <sub>gc</sub>	Gate-Collector ("Miller") Charge			390		
t <sub>d(on)</sub>	Turn-on Delay Time	<b>Resistive Switching (25°C)</b> V <sub>GE</sub> = 15V V <sub>CC</sub> = 0.8V <sub>CES</sub> I <sub>C</sub> = I <sub>C2</sub> R <sub>G</sub> = 5Ω		60		ns
t <sub>r</sub>	Rise Time			205		
t <sub>d(off)</sub>	Turn-off Delay Time			295		
t <sub>f</sub>	Fall Time			210		
t <sub>d(on)</sub>	Turn-on Delay Time	<b>Inductive Switching (150°C)</b> V <sub>CLAMP(Peak)</sub> = 0.66V <sub>CES</sub> V <sub>GE</sub> = 15V I <sub>C</sub> = I <sub>C2</sub> R <sub>G</sub> = 5Ω T <sub>J</sub> = +150°C		55		ns
t <sub>r</sub>	Rise Time			130		
t <sub>d(off)</sub>	Turn-off Delay Time			750		
t <sub>f</sub>	Fall Time			80		
E <sub>on</sub>	Turn-on Switching Energy <sup>④</sup>			9		
E <sub>off</sub>	Turn-off Switching Energy		10		mJ	
E <sub>ts</sub>	Total Switching Losses <sup>④</sup>		19			
t <sub>d(on)</sub>	Turn-on Delay Time	<b>Inductive Switching (25°C)</b> V <sub>CLAMP(Peak)</sub> = 0.66V <sub>CES</sub> V <sub>GE</sub> = 15V I <sub>C</sub> = I <sub>C2</sub> R <sub>G</sub> = 5Ω T <sub>J</sub> = +25°C		55		ns
t <sub>r</sub>	Rise Time			145		
t <sub>d(off)</sub>	Turn-off Delay Time			650		
t <sub>f</sub>	Fall Time			70		
E <sub>ts</sub>	Total Switching Losses <sup>④</sup>			17		
g <sub>fe</sub>	Forward Transconductance	V <sub>CE</sub> = 20V, I <sub>C</sub> = I <sub>C2</sub>	6			S

**THERMAL AND MECHANICAL CHARACTERISTICS (IGBT and FRED)**

Symbol	Characteristic	MIN	TYP	MAX	UNIT
R <sub>θJC</sub>	Junction to Case (IGBT)			0.24	°C/W
	Junction to Case (FRED)			0.66	
R <sub>θJA</sub>	Junction to Ambient			40	
W <sub>T</sub>	Package Weight		1.03		oz
			29.2		gm
Torque	Mounting Torque (Mounting = 8-32 or 4mm Machine and Terminals = 4mm Machine)			10	lb•in
				1.1	N•m

① Repetitive Rating: Pulse width limited by maximum junction temperature.

② Leakages include the FRED and IGBT.

③ See MIL-STD-750 Method 3471

④ Switching losses include the FRED and IGBT.

APT Reserves the right to change, without notice, the specifications and information contained herein.

# ULTRAFAST SOFT RECOVERY PARALLEL DIODE

**MAXIMUM RATINGS (FRED)**

All Ratings:  $T_C = 25^\circ\text{C}$  unless otherwise specified.

Symbol	Characteristic / Test Conditions	APT60GF120JRD	UNIT
$V_R$	Maximum D.C. Reverse Voltage	1200	Volts
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage		
$V_{RWM}$	Maximum Working Peak Reverse Voltage		
$I_F(AV)$	Maximum Average Forward Current ( $T_C = 60^\circ\text{C}$ , Duty Cycle = 0.5)	60	Amps
$I_F(RMS)$	RMS Forward Current	100	
$I_{FSM}$	Non-Repetitive Forward Surge Current ( $T_J = 45^\circ\text{C}$ , 8.3ms)	540	

**STATIC ELECTRICAL CHARACTERISTICS (FRED)**

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$V_F$	Maximum Forward Voltage		2.0	$I_F = 60\text{A}$	2.5
				$I_F = 120\text{A}$	
				$I_F = 60\text{A}, T_J = 150^\circ\text{C}$	2.0

**DYNAMIC CHARACTERISTICS (FRED)**

Symbol	Characteristic	MIN	TYP	MAX	UNIT
$t_{rr1}$	Reverse Recovery Time, $I_F = 1.0\text{A}$ , $di_F/dt = -15\text{A}/\mu\text{s}$ , $V_R = 30\text{V}$ , $T_J = 25^\circ\text{C}$		70	85	ns
$t_{rr2}$	Reverse Recovery Time		$T_J = 25^\circ\text{C}$ 70		
$t_{rr3}$	$I_F = 60\text{A}$ , $di_F/dt = -480\text{A}/\mu\text{s}$ , $V_R = 650\text{V}$		$T_J = 100^\circ\text{C}$ 130		
$t_{fr1}$	Forward Recovery Time		$T_J = 25^\circ\text{C}$ 170		
$t_{fr2}$	$I_F = 60\text{A}$ , $di_F/dt = 480\text{A}/\mu\text{s}$ , $V_R = 650\text{V}$		$T_J = 100^\circ\text{C}$ 170		
$I_{RRM1}$	Reverse Recovery Current		$T_J = 25^\circ\text{C}$ 18	30	Amps
$I_{RRM2}$	$I_F = 60\text{A}$ , $di_F/dt = -480\text{A}/\mu\text{s}$ , $V_R = 650\text{V}$		$T_J = 100^\circ\text{C}$ 29	40	
$Q_{rr1}$	Recovery Charge		$T_J = 25^\circ\text{C}$ 630		nC
$Q_{rr2}$	$I_F = 60\text{A}$ , $di_F/dt = -480\text{A}/\mu\text{s}$ , $V_R = 650\text{V}$		$T_J = 100^\circ\text{C}$ 1820		
$V_{fr1}$	Forward Recovery Voltage		$T_J = 25^\circ\text{C}$ 12		Volts
$V_{fr2}$	$I_F = 60\text{A}$ , $di_F/dt = 480\text{A}/\mu\text{s}$ , $V_R = 650\text{V}$		$T_J = 100^\circ\text{C}$ 12		
$diM/dt$	Rate of Fall of Recovery Current		$T_J = 25^\circ\text{C}$ 900		A/ $\mu\text{s}$
	$I_F = 60\text{A}$ , $di_F/dt = -480\text{A}/\mu\text{s}$ , $V_R = 650\text{V}$		$T_J = 100^\circ\text{C}$ 600		

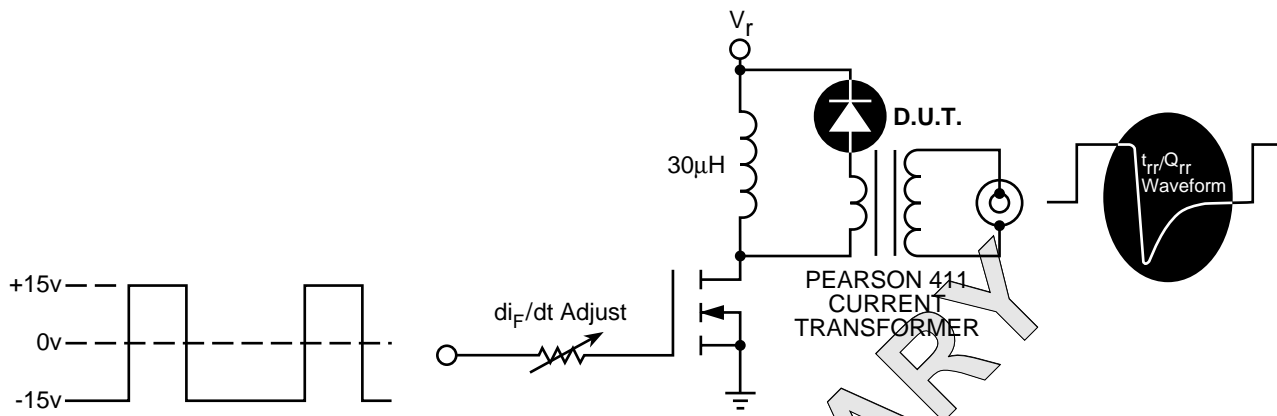
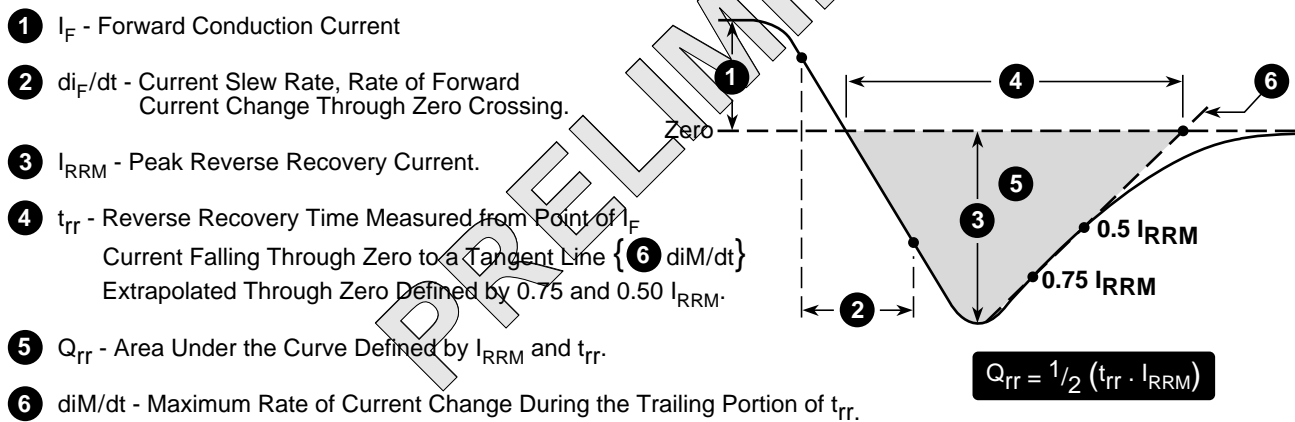
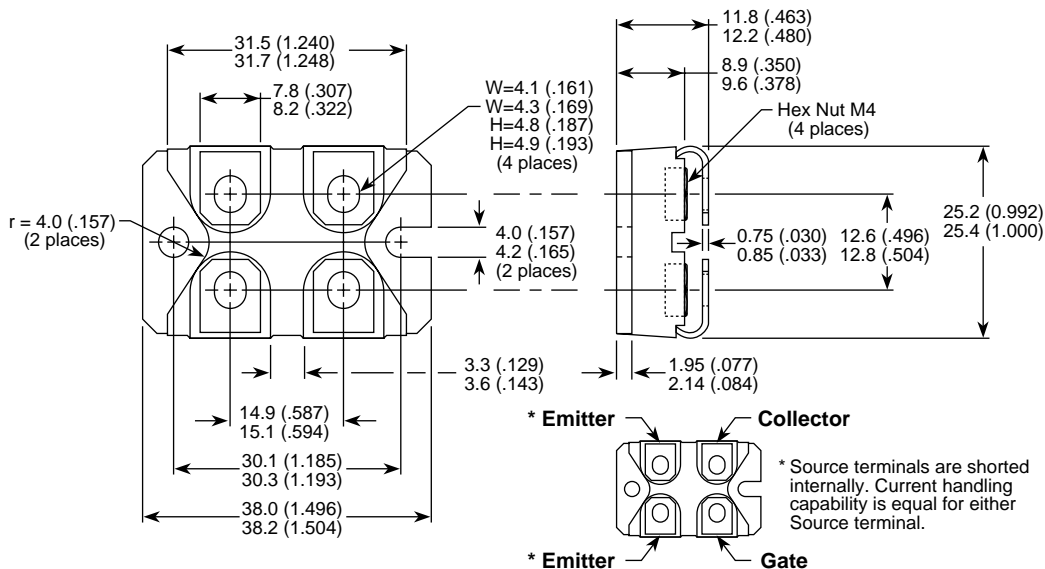


Figure 25, Diode Reverse Recovery Test Circuit and Waveforms



- 1  $I_F$  - Forward Conduction Current
- 2  $di_F/dt$  - Current Slew Rate, Rate of Forward Current Change Through Zero Crossing.
- 3  $I_{RRM}$  - Peak Reverse Recovery Current.
- 4  $t_{rr}$  - Reverse Recovery Time Measured from Point of  $I_F$  Current Falling Through Zero to a Tangent Line { 6  $di_M/dt$  } Extrapolated Through Zero Defined by 0.75 and 0.50  $I_{RRM}$ .
- 5  $Q_{rr}$  - Area Under the Curve Defined by  $I_{RRM}$  and  $t_{rr}$ .
- 6  $di_M/dt$  - Maximum Rate of Current Change During the Trailing Portion of  $t_{rr}$ .

SOT-227 (ISOTOP®) Package Outline



Dimensions in Millimeters and (Inches)